

SCES753C - SEPTEMBER 2009-REVISED MAY 2010

 $V_{\text{cc}}$ 

1Y

2B

2A

### LOW-POWER DUAL 2-INPUT POSITIVE-NOR GATE

Check for Samples: SN74AUP2G02

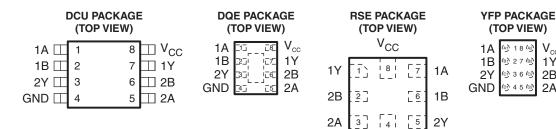
#### FEATURES

- Available in the Texas Instruments NanoStar™ Package
- Low Static-Power Consumption  $(I_{CC} = 0.9 \ \mu A Maximum)$
- Low Dynamic-Power Consumption  $(C_{pd} = 4.3 \text{ pF Typ at } 3.3 \text{ V})$
- Low Input Capacitance (C<sub>i</sub> = 1.5 pF Typical)
- Low Noise Overshoot and Undershoot <10% of V<sub>CC</sub>
- Ioff Supports Partial-Power-Down Mode • Operation
- Wide Operating V<sub>CC</sub> Range of 0.8 V to 3.6 V

- **Optimized for 3.3-V Operation**
- 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- t<sub>nd</sub> = 4.3 ns Maximum at 3.3 V
- Suitable for Point-to-Point Applications
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
  - 2000-V Human-Body Model (A114-B, Class II)

GND

1000-V Charged-Device Model (C101)



See mechanical drawings for dimensions.

#### DESCRIPTION/ORDERING INFORMATION

The AUP family is TI's premier solution to the industry's low-power needs in battery-powered portable applications. This family ensures a very low static- and dynamic-power consumption across the entire V<sub>CC</sub> range of 0.8 V to 3.6 V, resulting in increased battery life (see Figure 1). This product also maintains excellent signal integrity (see the very low undershoot and overshoot characteristics shown in Figure 2).

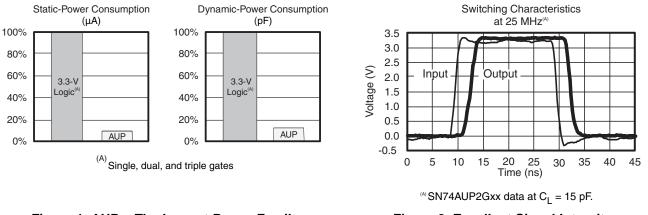




Figure 2. Excellent Signal Integrity

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

AA)

### SN74AUP2G02

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The SN74AUP2G02 performs the Boolean function  $Y = \overline{A + B}$  or  $Y = \overline{A} \cdot \overline{B}$  in positive logic.

NanoStar<sup>™</sup> package technology is a major breakthrough in IC packaging concepts, using the die as the package.

This device is fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

#### **ORDERING INFORMATION**<sup>(1)</sup>

T <sub>A</sub>	PACKAGE <sup>(2)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING <sup>(3)</sup>
	NanoStar™  – WCSP (DSBGA) 0.23-mm Large Bump – YFP (Pb-free)	Reel of 3000	SN74AUP2G02YFPR	H B _
–40°C to 85°C	uQFN – DQE	Reel of 5000	SN74AUP2G02DQER	PP
	QFN – RSE	Reel of 5000	SN74AUP2G02RSER	PP
	SSOP – DCU	Reel of 3000	SN74AUP2G02DCUR	H02_

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

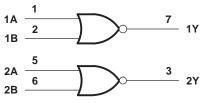
(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

(3) DCU: The actual top-side marking has one additional character that designates the wafer fab/assembly site. YFP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the wafer fab/assembly site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, • = Pb-free).

#### FUNCTION TABLE (EACH GATE)

INPU	OUTPUT	
Α	В	Y
Н	Х	L
х	Н	L
L	L	Н

#### LOGIC DIAGRAM (POSITIVE LOGIC)



Pin number shown are for DCU and DQE packages.



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#### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	4.6	V
VI	Input voltage range <sup>(2)</sup>		-0.5	4.6	V
Vo	Voltage range applied to any output in the I	high-impedance or power-off state <sup>(2)</sup>	-0.5	4.6	V
Vo	Output voltage range in the high or low stat	e <sup>(2)</sup>	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
lo	Continuous output current		±20	mA	
	Continuous current through $V_{CC}$ or GND			±50	mA
		DCU package		220	
0	Declare thermal impedance $^{(3)}$	RSE package		253	°C/W
$\theta_{JA}$	O <sub>JA</sub> Package thermal impedance <sup>(3)</sup>	YFP package		132	°C/w
		DQE package		261	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating" conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) (3) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

The package thermal impedance is calculated in accordance with JESD 51-7.

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#### **RECOMMENDED OPERATING CONDITIONS**<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		0.8	3.6	V
		$V_{CC} = 0.8 V$	V <sub>CC</sub>		
V		$V_{CC}$ = 1.1 V to 1.95 V	$0.65 \times V_{CC}$		V
VIH	High-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V	1.6		V
		$V_{CC}$ = 3 V to 3.6 V	2		
		$V_{CC} = 0.8 V$		0	
V		$V_{CC}$ = 1.1 V to 1.95 V		0.35 × V <sub>CC</sub>	V
VIL	Low-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V		0.7	V
		$V_{CC}$ = 3 V to 3.6 V		0.9	
VI	Input voltage		0	3.6	V
Vo	Output voltage		0	V <sub>CC</sub>	V
		V <sub>CC</sub> = 0.8 V		-20	μA
		V <sub>CC</sub> = 1.1 V		-1.1	
		$V_{CC} = 1.4 V$		-1.7	
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 1.65		-1.9	mA
		$V_{CC} = 2.3 V$		-3.1	
		$V_{CC} = 3 V$		-4	
		$V_{CC} = 0.8 V$		20	μA
		V <sub>CC</sub> = 1.1 V		1.1	
		$V_{CC} = 1.4 V$		1.7 1.9	
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 1.65 V			
		V <sub>CC</sub> = 2.3 V	3.1		
		V <sub>CC</sub> = 3 V		4	
Δt/Δv	Input transition rise or fall rate	$V_{CC} = 0.8 V \text{ to } 3.6 V$		200	ns/V
T <sub>A</sub>	Operating free-air temperature		-40	85	°C

(1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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#### **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	TEST CONDITIONS	V	T <sub>A</sub>	= 25°C	T <sub>A</sub> = -40°C	to 85°C	UNIT
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP MAX	MIN	MAX	UNIT
	I <sub>OH</sub> = -20 μA	0.8 V to 3.6 V	V <sub>CC</sub> – 0.1		V <sub>CC</sub> - 0.1		
	I <sub>OH</sub> = -1.1 mA	1.1 V	0.75 × V <sub>CC</sub>		0.7 × V <sub>CC</sub>		
	I <sub>OH</sub> = -1.7 mA	1.4 V	1.11		1.03		
	I <sub>OH</sub> = -1.9 mA	1.65 V	1.32		1.3		V
V <sub>OH</sub>	I <sub>OH</sub> = -2.3 mA	2.2.1/	2.05		1.97		V
	I <sub>OH</sub> = -3.1 mA	2.3 V	1.9		1.85		
	I <sub>OH</sub> = -2.7 mA	0.14	2.72		2.67		
	$I_{OH} = -4 \text{ mA}$	3 V	2.6		2.55		
	I <sub>OL</sub> = 20 μA	0.8 V to 3.6 V		0.1		0.1	V
.,	I <sub>OL</sub> = 1.1 mA	1.1 V		0.3 × V <sub>CC</sub>		$0.3 \times V_{CC}$	
	I <sub>OL</sub> = 1.7 mA	1.4 V		0.31		0.37	
	I <sub>OL</sub> = 1.9 mA	1.65 V		0.31		0.35	
V <sub>OL</sub>	I <sub>OL</sub> = 2.3 mA	2.2.1/		0.31		0.33	
	I <sub>OL</sub> = 3.1 mA	2.3 V		0.44		0.45	
	I <sub>OL</sub> = 2.7 mA	2.1/		0.31		0.33	
	I <sub>OL</sub> = 4 mA	3 V		0.44		0.45	
II A or B input	$V_1 = GND$ to 3.6 V	0 V to 3.6 V		0.1		0.5	μA
off	$V_1 \text{ or } V_0 = 0 \text{ V to } 3.6 \text{ V}$	0 V		0.2		0.6	μA
Δl <sub>off</sub>	$V_{I}$ or $V_{O} = 0$ V to 3.6 V	0 V to 0.2 V		0.2		0.6	μA
Icc		0.8 V to 3.6 V		0.5		0.9	μΑ
ΔI <sub>CC</sub>	$V_{I} = V_{CC} - 0.6 V^{(1)},$ $I_{O} = 0$	3.3 V		40		50	μA
0		0 V		1.5			~ <b>F</b>
Ci	$V_I = V_{CC}$ or GND	3.6 V		1.5			pF
C <sub>o</sub>	V <sub>O</sub> = GND	0 V		3			pF

(1) One input at  $V_{CC}$  – 0.6 V, other input at  $V_{CC}$  or GND

#### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range,  $C_L = 5 \text{ pF}$  (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM	то	V	Τ,	<sub>λ</sub> = 25°C	;	T <sub>A</sub> = −40°C t	o 85°C	UNIT
PARAMETER	(INPUT)	(OUTPUT)	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	UNIT
			0.8 V		18				
		A or B X	1.2 V ± 0.1 V	2.6	7.3	12.8	2.1	15.6	
	A or B		1.5 V ± 0.1 V	1.4	5.2	8.7	0.9	10.3	20
t <sub>pd</sub>	AUD	ř	1.8 V ± 0.15 V	1	4.2	6.6	0.5	8.2	ns
			2.5 V ± 0.2 V	1	3	4.4	0.5	5.5	
			3.3 V ± 0.3 V	1	2.4	3.5	0.5	4.3	



#### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, C<sub>L</sub> = 10 pF (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM	то	V	T,	ק = 25°C		T <sub>A</sub> = −40°C t	o 85°C	UNIT
FARAMETER	(INPUT)	(OUTPUT)	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	UNIT
		0.8 V		21					
			1.2 V ± 0.1 V	1.5	8.5	14.7	1	17.2	
		~	1.5 V ± 0.1 V	1	6.2	10	0.5	11.3	~~~
t <sub>pd</sub>	A or B	Ť	1.8 V ± 0.15 V	1	5	7.7	0.5	9	ns
		2.5 V ± 0.2 V	1	3.6	5.2	0.5	6.1		
		3.3 V ± 0.3 V	1	2.9	4.2	0.5	4.7		

#### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range,  $C_L = 15 \text{ pF}$  (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM	то	V	$T_{A} = 25^{\circ}$			$T_A = -40^{\circ}C$ to $85^{\circ}C$		UNIT
PARAMETER	(INPUT)	(OUTPUT)	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	UNIT
			0.8 V		24				
			1.2 V ± 0.1 V	3.6	9.9	16.3	3.1	19.9	
	A	v	1.5 V ± 0.1 V	2.3	7.2	11.1	1.8	13.2	
t <sub>pd</sub>	A or B	ř	1.8 V ± 0.15 V	1.6	5.8	8.7	1.1	10.6	ns
			2.5 V ± 0.2 V	1	4.3	5.9	0.5	7.3	
		3.3 V ± 0.3 V	1	3.4	4.8	0.5	5.9		

#### SWITCHING CHARACTERISTICS

over recommended operating free-air temperature range, C<sub>L</sub> = 30 pF (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM	то	N	T <sub>A</sub> =			T <sub>A</sub> = -40°C to 85°C		UNIT
PARAMETER	(OUTPUT) (OUTPUT)	V <sub>cc</sub>	MIN	TYP	MAX	MIN	MAX	UNIT	
t <sub>pd</sub> A or B		0.8 V		32.8					
		×	1.2 V ± 0.1 V	4.9	13.1	20.9	4.4	25.5	
	A		1.5 V ± 0.1 V	3.4	9.5	14.2	2.9	16.9	20
	Ŷ	1.8 V ± 0.15 V	2.5	7.7	11	2	13.5	ns	
			2.5 V ± 0.2 V	1.8	5.7	7.6	1.3	9.4	
			3.3 V ± 0.3 V	1.5	4.7	6.2	1	7.5	

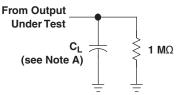
#### **OPERATING CHARACTERISTICS**

 $T_A = 25^{\circ}C$ 

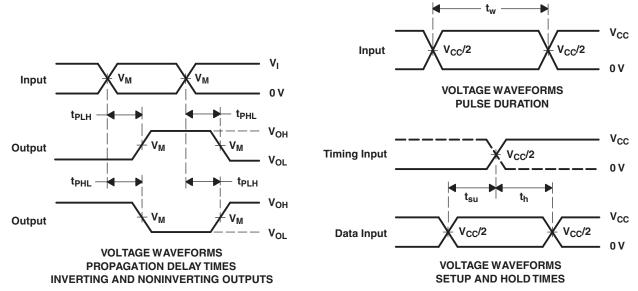
	PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	TYP	UNIT
			0.8 V	4	
			1.2 V ± 0.1 V	4	pF
C	Dower discipation conscitance	f = 10 MHz	1.5 V ± 0.1 V	4	
C <sub>pd</sub>	Power dissipation capacitance		1.8 V ± 0.15 V	4	
			2.5 V ± 0.2 V	4.1	
			3.3 V ± 0.3 V	4.3	

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#### PARAMETER MEASUREMENT INFORMATION (Propagation Delays, Setup and Hold Times, and Pulse Width)



	V <sub>CC</sub> = 0.8 V	V <sub>CC</sub> = 1.2 V ± 0.1 V	$V_{CC}$ = 1.5 V ± 0.1 V	V <sub>CC</sub> = 1.8 V ± 0.15 V	$V_{CC}$ = 2.5 V $\pm$ 0.2 V	$V_{CC}$ = 3.3 V $\pm$ 0.3 V
CL	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
V <sub>M</sub>	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2
VI	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>



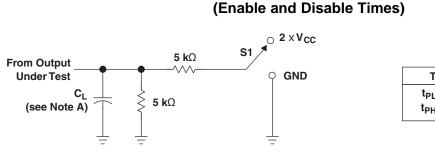
- A. C<sub>L</sub> includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>0</sub> = 50  $\Omega$ , for propagation delays t<sub>f</sub>/t<sub>f</sub> = 3 ns, for setup and hold times and pulse width t<sub>f</sub>/t<sub>f</sub> = 1.2 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- F. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

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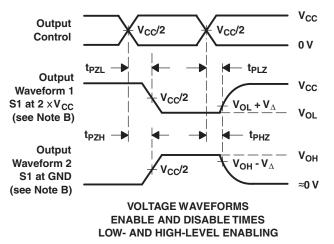


TEST	S1
t <sub>PLZ</sub> /t <sub>PZL</sub>	2 × V <sub>CC</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

LOAD CIRCUIT

	V <sub>CC</sub> = 0.8 V	V <sub>CC</sub> = 1.2 V ± 0.1 V	V <sub>CC</sub> = 1.5 V ± 0.1 V	V <sub>CC</sub> = 1.8 V ± 0.15 V	$V_{CC}$ = 2.5 V $\pm$ 0.2 V	$V_{CC} = 3.3 \text{ V}$ $\pm 0.3 \text{ V}$
С <sub>L</sub>	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
V <sub>M</sub>	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2	V <sub>CC</sub> /2
V <sub>I</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>
V <sub>Δ</sub>	0.1 V	0.1 V	0.1 V	0.15 V	0.15 V	0.3 V

PARAMETER MEASUREMENT INFORMATION



- A. C<sub>L</sub> includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>0</sub> = 50  $\Omega$ , t<sub>r</sub>/t<sub>f</sub> = 3 ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- G. All parameters and waveforms are not applicable to all devices.

#### Figure 4. Load Circuit and Voltage Waveforms

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#### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
SN74AUP2G02DCUR	ACTIVE	VSSOP	DCU	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	H02R	Samples
SN74AUP2G02DQER	ACTIVE	X2SON	DQE	8	5000	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	PP	Samples
SN74AUP2G02RSER	ACTIVE	UQFN	RSE	8	5000	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	PP	Samples
SN74AUP2G02YFPR	ACTIVE	DSBGA	YFP	8	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-40 to 85	HBN	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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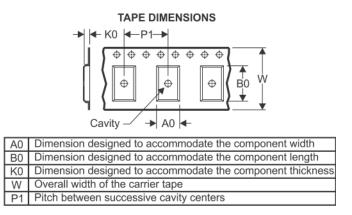
### PACKAGE MATERIALS INFORMATION

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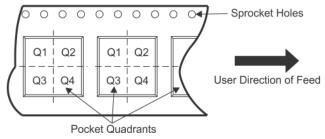
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#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



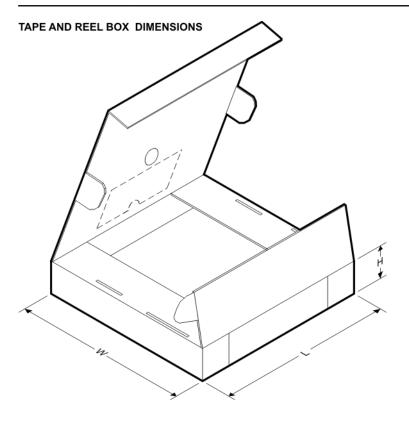
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AUP2G02DCUR	VSSOP	DCU	8	3000	180.0	8.4	2.25	3.35	1.05	4.0	8.0	Q3
SN74AUP2G02DQER	X2SON	DQE	8	5000	180.0	8.4	1.2	1.6	0.55	4.0	8.0	Q1
SN74AUP2G02RSER	UQFN	RSE	8	5000	180.0	8.4	1.7	1.7	0.7	4.0	8.0	Q2
SN74AUP2G02YFPR	DSBGA	YFP	8	3000	178.0	9.2	0.9	1.75	0.6	4.0	8.0	Q1

TEXAS INSTRUMENTS

www.ti.com

### PACKAGE MATERIALS INFORMATION

18-Jan-2020



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AUP2G02DCUR	VSSOP	DCU	8	3000	202.0	201.0	28.0
SN74AUP2G02DQER	X2SON	DQE	8	5000	202.0	201.0	28.0
SN74AUP2G02RSER	UQFN	RSE	8	5000	202.0	201.0	28.0
SN74AUP2G02YFPR	DSBGA	YFP	8	3000	220.0	220.0	35.0

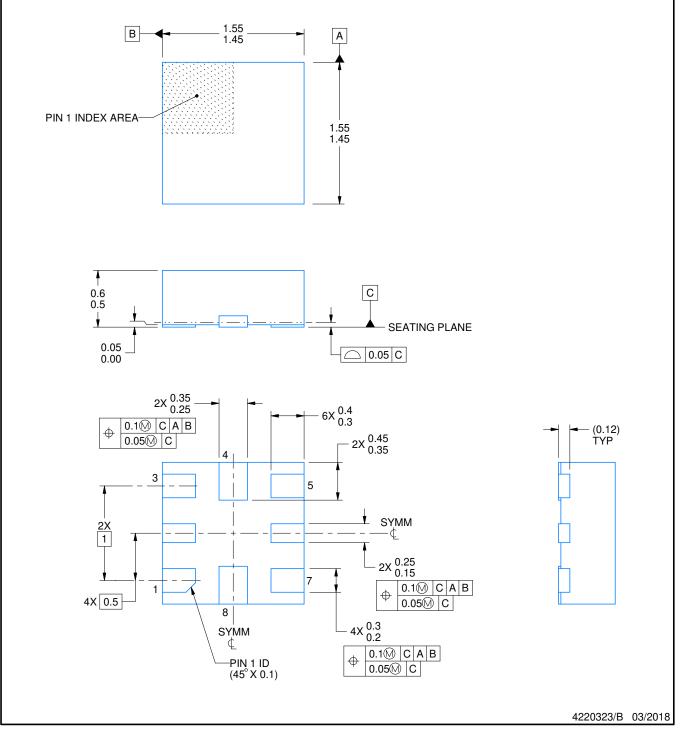
## **RSE0008A**



## **PACKAGE OUTLINE**

### UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.

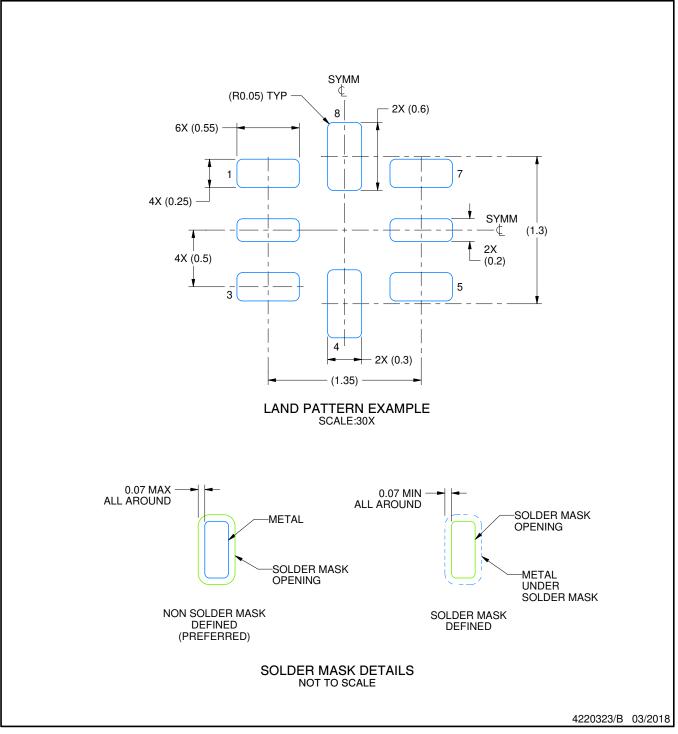


## RSE0008A

## **EXAMPLE BOARD LAYOUT**

### UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

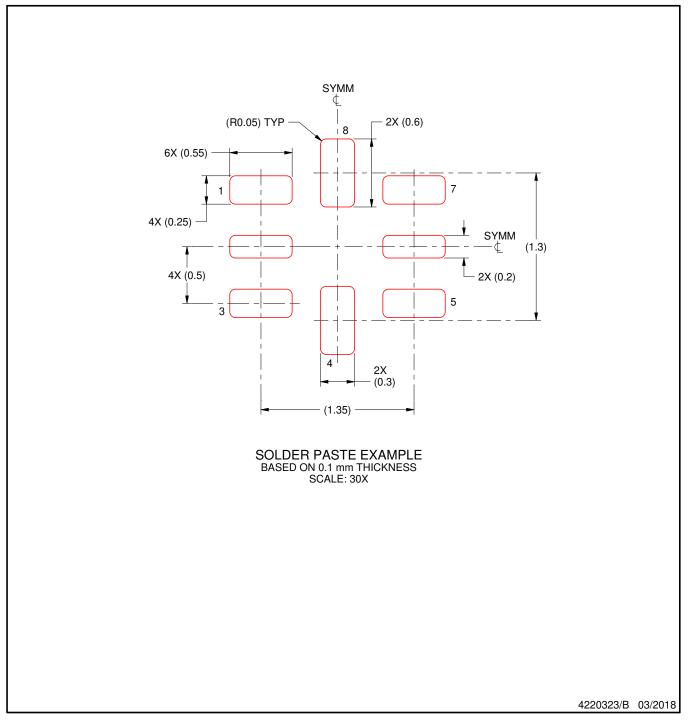


### **RSE0008A**

## **EXAMPLE STENCIL DESIGN**

### UQFN - 0.6 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



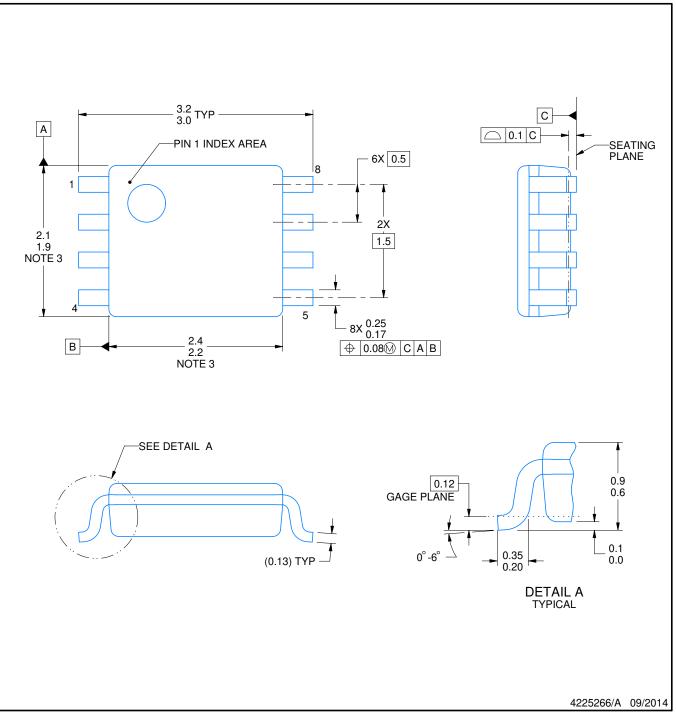
## **DCU0008A**



## **PACKAGE OUTLINE**

### VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side. 4. Reference JEDEC registration MO-187 variation CA.

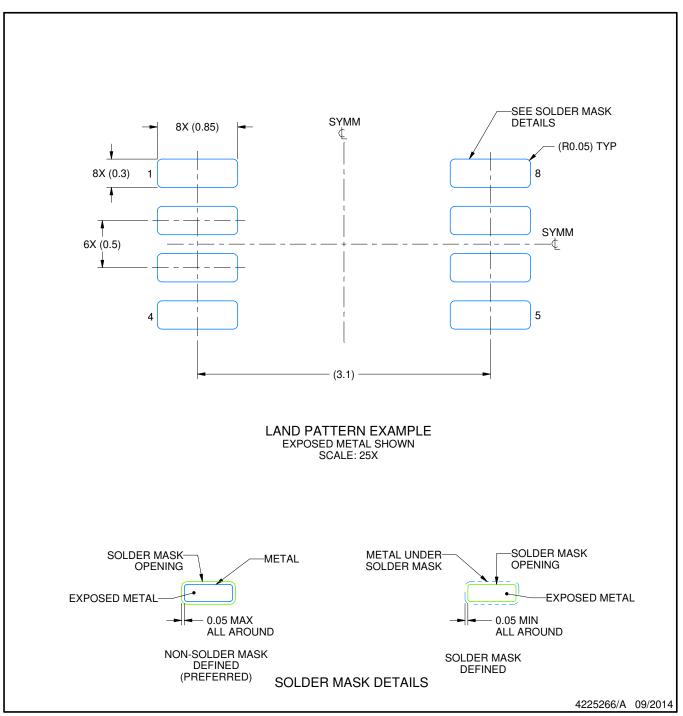


## DCU0008A

## **EXAMPLE BOARD LAYOUT**

#### VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

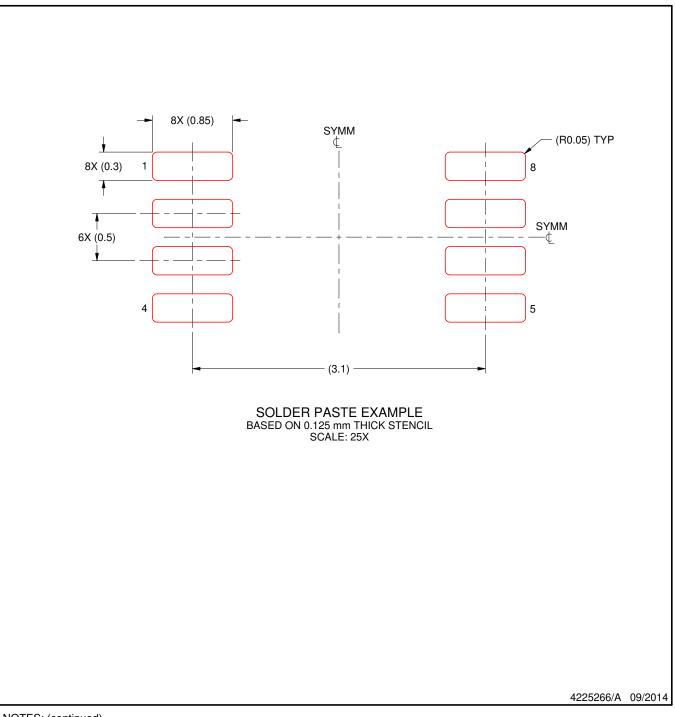


## DCU0008A

## **EXAMPLE STENCIL DESIGN**

### VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

8. Board assembly site may have different recommendations for stencil design.



<sup>7.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

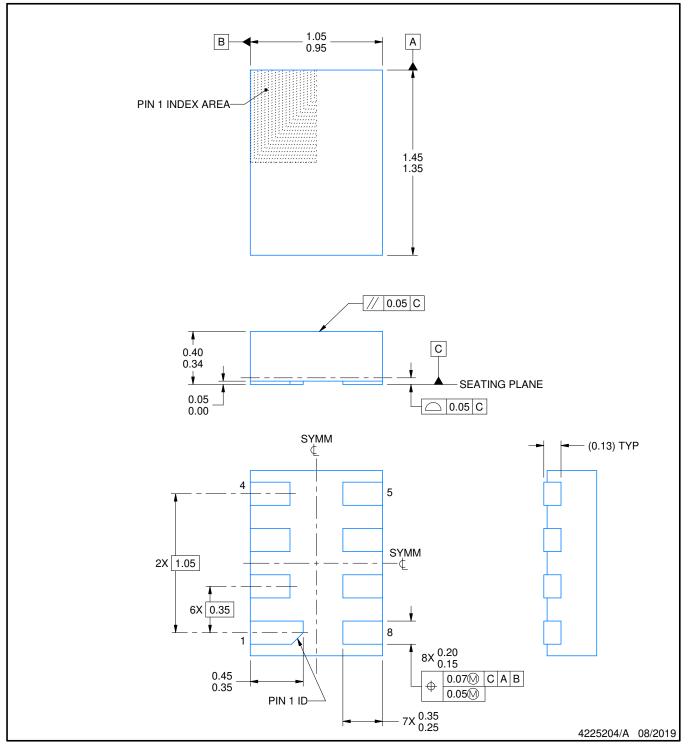
## **DQE0008A**



### **PACKAGE OUTLINE**

#### X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
  This drawing is subject to change without notice.
  This package complies to JEDEC MO-287 variation X2EAF.

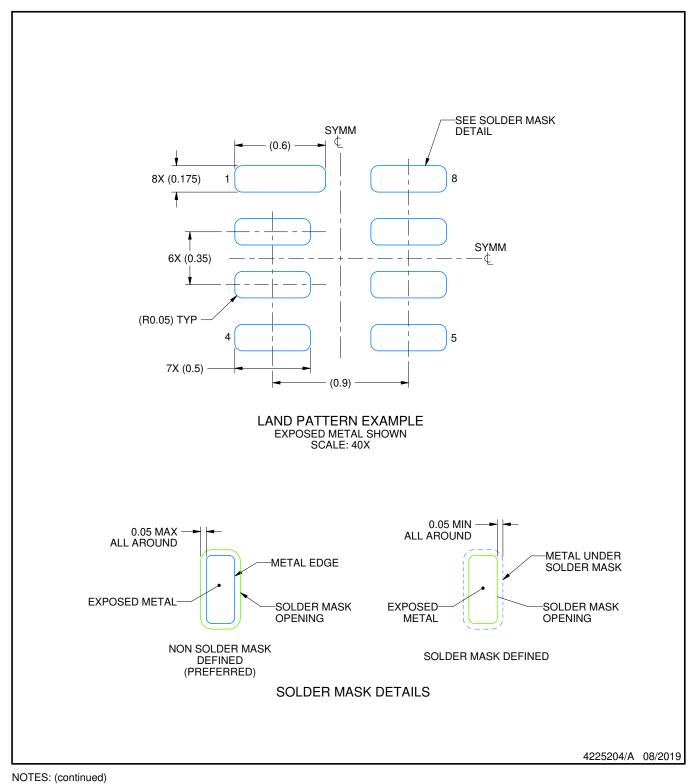


## **DQE0008A**

## **EXAMPLE BOARD LAYOUT**

#### X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

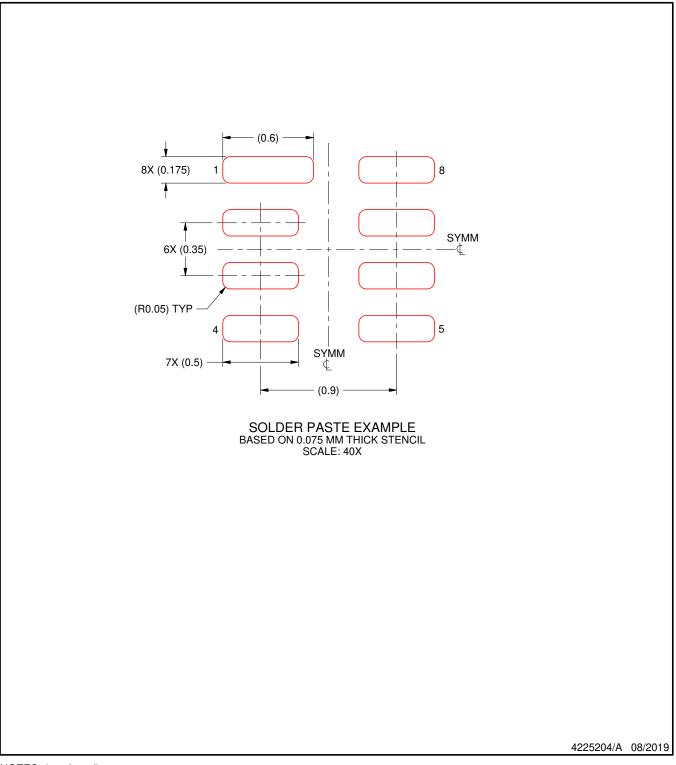


## **DQE0008A**

## **EXAMPLE STENCIL DESIGN**

### X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



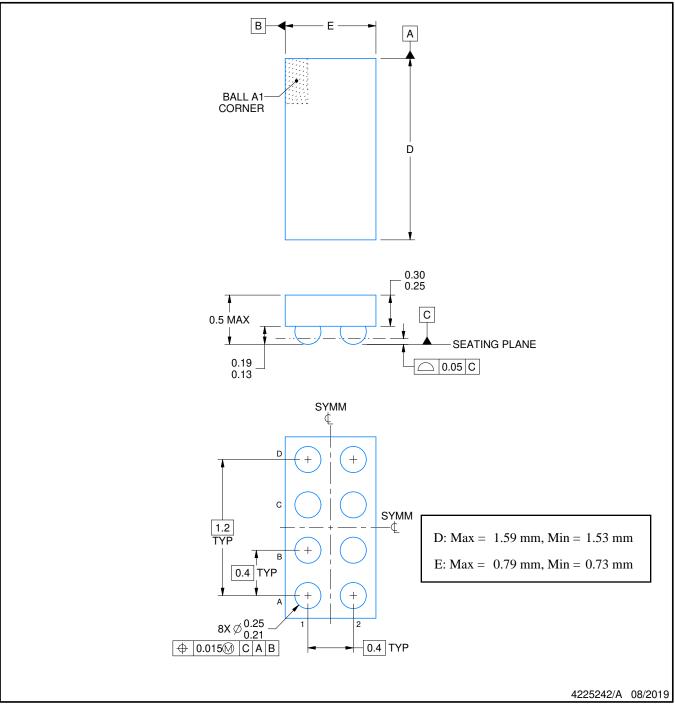
## **YFP0008**



## **PACKAGE OUTLINE**

### DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.

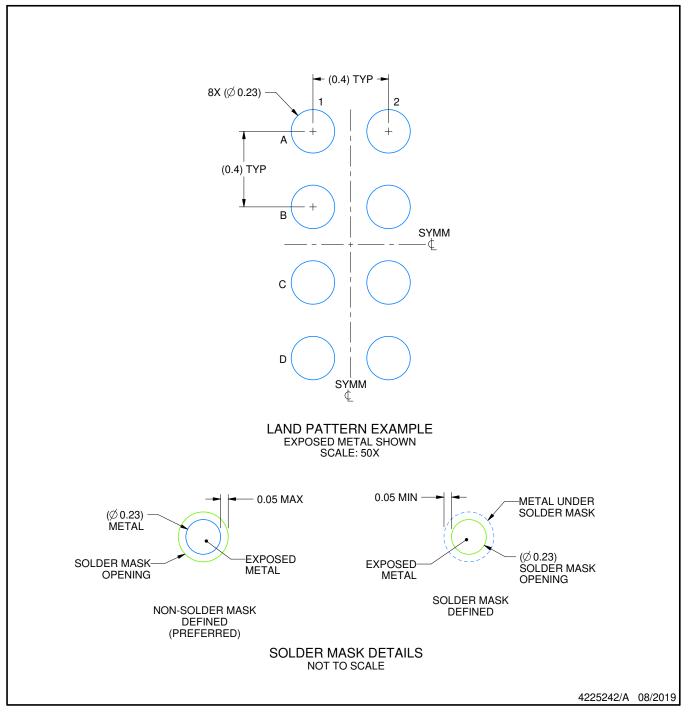


## YFP0008

## **EXAMPLE BOARD LAYOUT**

### DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. See Texas Instruments Literature No. SNVA009 (www.ti.com/lit/snva009).

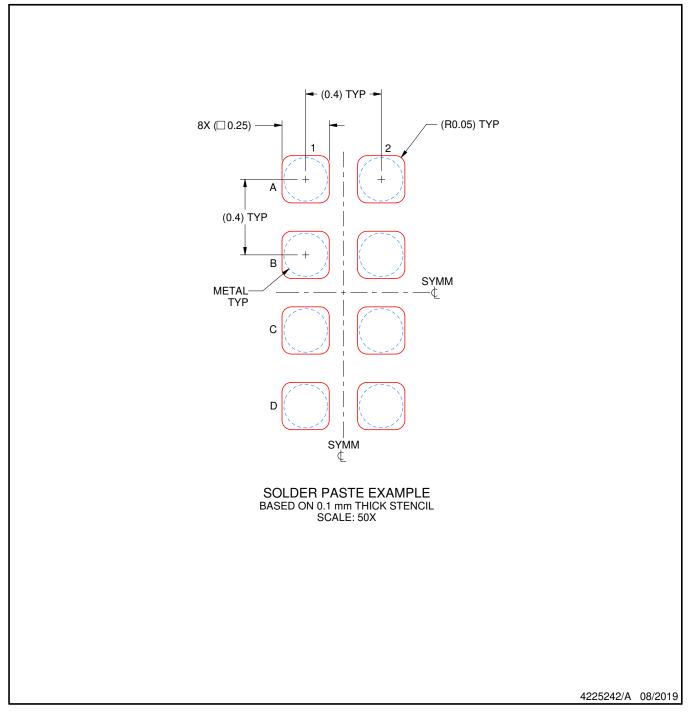


## YFP0008

## **EXAMPLE STENCIL DESIGN**

### DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



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